Notice of References Cited	
----------------------------	--

Application/Control No.	Applicant(s)/Pater	nt Under
10/802,589	Reexamination HAWKINS ET AL	
Examiner	Art Unit	
Ryan Stronczer	4157	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,248,946 B1	06-2001	Dwek, Norman Scott	84/609
*	В	US-6,243,725 B1	06-2001	Hempleman et al.	715/530
*	O	US-2001/0053944 A1	12-2001	Marks et al.	700/94
*	D	US-2002/0042923 A1	04-2002	Asmussen et al.	725/92
*	Е	US-2002/0152278 A1	10-2002	Pontenzone et al.	709/217
*	F	US-2004/0215733 A1	10-2004	Gondhalekar et al.	709/207
*	G	US-2004/0267774 A1	12-2004	Lin et al.	707/100
	Н	US-		-	
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U			
	v			
	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.